

DOCKET NO: 241677US-2



IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF

KENJI YOSHIDA, ET AL.

: EXAMINER: STEVENSON, A.

SERIAL NO: 10/642,222

:

FILED: AUGUST 18, 2003

: GROUP ART UNIT: 2812

FOR: METHOD OF ACCELERATING
TEST OF SEMICONDUCTOR DEVICE

AMENDMENT

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated May 17, 2006, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 5 of this paper.